

Search Notes

Application/Control No.

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Examiner

Thien F. Tran

Applicant(s)/Patent under
Reexamination

NARENDRA ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
257	707, 717 719, 778	10/25/2005	TT
Above	updated	2/23/2006	TT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR